January 2001



Si4466DY

Single N-Channel 2.5V Specified PowerTrench® MOSFET

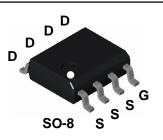
General Description

This N-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

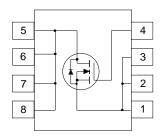
Applications

- DC/DC converter
- Load switch
- Battery protection



Features

- 15 A, 20 V. $R_{DS(on)} = 0.0075 \ \Omega \ @ V_{GS} = 4.5 \ V$ $R_{DS(on)} = 0.010 \ \Omega \ @ V_{GS} = 2.5 \ V.$
- Low gate charge (47nC typical).
- Fast switching speed.
- High performance trench technology for extremely low R_{DS(ON)}.
- High power and current handling capability.



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	V
b	Drain Current - Continuous	(Note 1a)	15	А
	- Pulsed		50	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R _θ JA	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta^{JC}}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	∘C/W

Package Outlines and Ordering Information

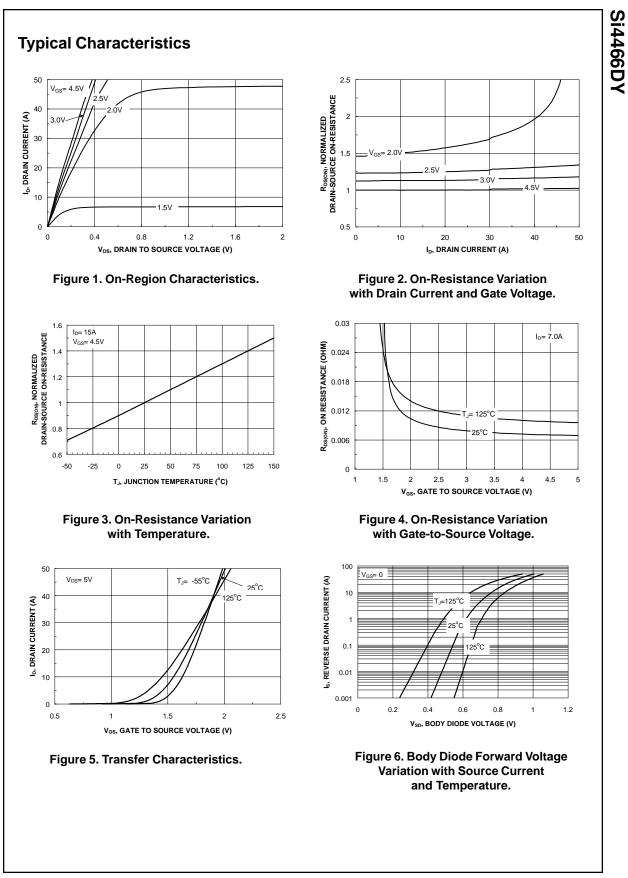
Device Marking	Device	Reel Size	Tape Width	Quantity
4466	Si4466DY	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Char	acteristics	ļ				
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	20			V
<u>ΔBV_{DSS}</u> ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A$, Referenced to $25^{\circ}C$		29		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 12 V, V_{DS} = 0 V$			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -12 V, V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.4	0.9	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250\mu A$, Referenced to $25^{\circ}C$		-4		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 V, I_D = 15 A$ $V_{GS} = 4.5 V, I_D = 15 A,$ $T_{J}=125^{\circ}C$ $V_{GS} = 2.5 V, I_D = 12 A$		0.006 0.009 0.008	0.0075 0.0130 0.0100	Ω
I _{D(on)}	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5.0 \text{ V}$	25			Α
g fs	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		70		S
Dynamic	Characteristics					
Ciss	Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		4700		pF
Coss	Output Capacitance	f = 1.0 MHz		850		pF
C _{rss}	Reverse Transfer Capacitance			310		pF
Switchin	g Characteristics (Note 2)	•				.
t _{d(on)}	Turn-On Delay Time	$\label{eq:VDD} \begin{split} V_{DD} &= 10 \text{ V}, \text{ I}_D = 1 \text{ A}, \\ V_{GS} &= 4.5 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega \end{split}$		20	32	ns
tr	Turn-On Rise Time			27	44	ns
t _{d(off)}	Turn-Off Delay Time			95	133	ns
t _f	Turn-Off Fall Time			35	56	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 15 \text{ A},$		47	66	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 5 V,$		7		nC
Q _{gd}	Gate-Drain Charge			10.5		nC
Drain-Sc	ource Diode Characteristics an	d Maximum Ratings				
ls	Maximum Continuous Drain-Sou				2.1	Α
	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)		0.65	1.2	V
V _{SD} Notes: 1. R _{θJA} is the		$V_{GS} = 0 \text{ V}, \text{ I}_S = 2.1 \text{ A}$ (Note 2) sistance where the case thermal reference is ned by the user's board design.	a defined a	as the sold	1.2	V surface o

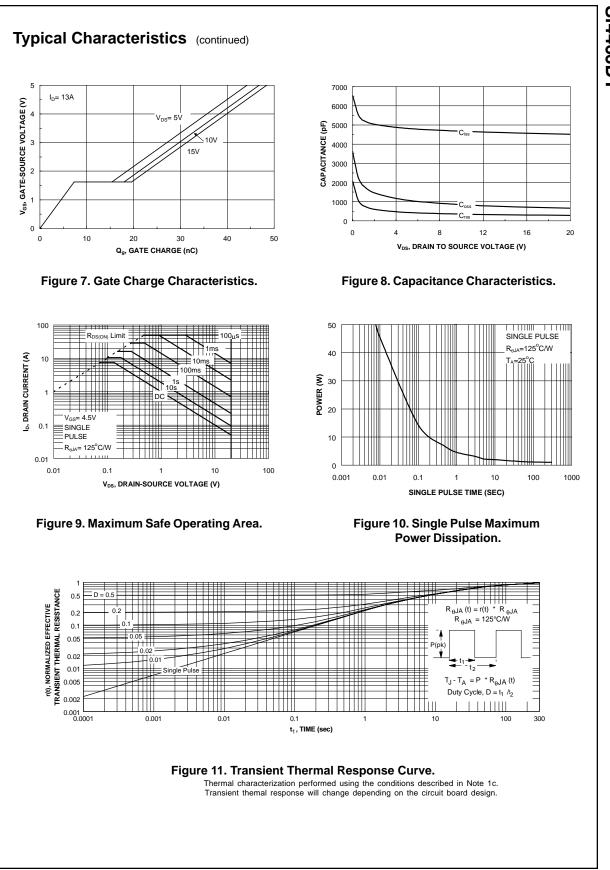
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2.0%

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Si4466DY Rev. A



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